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PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application No.: 10/809,143

Filed: March 25, 2004

Inventor(s):

Christopher G. Cifra, Philippe G.
Joffrain, Alain G. Moriat,
Christophe A. Restat, John A.
Pasquarette, and J. Clinton
Fletcher

Title: Automatic Configuration of
Function Blocks In A Signal
Analysis System

§ Examiner: Unknown
§ Group/Art Unit: 2186
§ Atty. Dkt. No: 5150-82400
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I hereby certify that this correspondence is being deposited with the United States Postal Service with sufficient postage as first class mail in an envelope addressed to Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450 on the date indicated below.

Jeffrey C. Hood

Jeffrey C. Hood 3/1/2005
Signature Date

INFORMATION DISCLOSURE STATEMENT

Mail Stop Amendment
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

Applicant requests consideration of ☒ the references listed on the attached Form PTO-1449 and/or ☐ the additional information identified below in paragraph 3. A copy of references A15-A76 and A91 listed on the Form PTO-1449 are enclosed.

1. This Information Disclosure Statement is submitted:

- a. ☐ within 3 months of the filing date of a national application other than a continued prosecution application under § 1.53(d);
☐ within 3 months of the date of entry of the national stage as set forth in § 1.491 in an International application;
☒ before the mailing date of a first Office Action on the merits; or
☐ before the mailing of a first Office Action after the filing of a request for continued examination under § 1.114.

- b. ☐ after the events of above paragraph 1a and prior to the mailing date of a final Office Action or Notice of Allowance, and thus: ☐ the certification of paragraph 2 below is provided, or ☐ a fee of \$180.00 is enclosed below.
- c. ☐ after the mailing date of a final Office Action or a Notice of Allowance and prior to payment of the issue fee, and thus: the certification of paragraph 2 below is provided and a fee of \$180.00 is enclosed below.
2. It is hereby certified:
- ☐ that each item of information contained in this Information Disclosure Statement was cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of the Statement, or
- ☐ that no item of information contained in the Information Disclosure Statement was cited in a communication from a foreign patent office in a counterpart foreign application or, to the knowledge of the person signing the certification after making reasonable inquiry, was known to any individual designated in § 1.56 (c) more than three months prior to the filing of the Statement.
3. ☐ Consideration of the following additional information (including any co-pending or abandoned U.S. applications, prior uses and/or sales, etc.) is requested:
4. For each non-English language reference listed on the attached Form PTO-1449:
- ☐ reference is made to an English language translation submitted herewith, and/or
- ☐ reference is made to a foreign patent office search report (in the English language) submitted herewith, and/or
- ☐ reference is made to an English language translation of a foreign patent office search report submitted herewith, and/or
- ☐ reference is made to the concise explanation contained in the specification of the present application at page(s) _____, and/or
- ☐ reference is made to the concise explanation set forth below:
5. ☐ Applicant also offers the following comments for the Examiner's consideration:
6. ☐ Also enclosed is a copy of a foreign search report citing these references.
7. ☐ The listed documents were brought to the attention of the Applicant(s) after payment of the issue fee in the captioned case. The documents were cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this Information Disclosure Statement. Applicant(s) request this Information Disclosure Statement and attached Form PTO-1449 be placed in the file of the captioned application.

8. ☐ Applicant(s) requests that the Information Disclosure Statement and attached Form PTO-1449 and references, which are being filed before the grant of the patent and pursuant to 37 C.F.R. § 1.97(i), be placed in the file of the captioned application.

Applicant does not believe that any fees are required relating to this Information Disclosure Statement. The Commissioner is hereby authorized to charge any fees which may be required or credit any overpayment to Meyertons, Hood, Kivlin, Kowert & Goetzel PC, Deposit Account No. 50-1505/5150-82400/JCH.

Respectfully submitted,



Jeffrey C. Hood
Reg. No. 35,198
Attorney for Applicant(s)

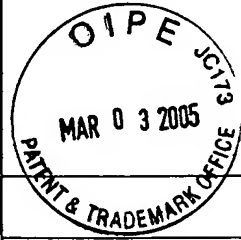
MEYERTONS HOOD KIVLIN KOWERT & GOETZEL PC
P. O. Box 398
Austin, Texas 78767
(512) 853-8800

Date: 3/1/2005

Form PTO-1449 (modified)
List of Patents and Publications
For Applicant's Information
Disclosure Statement
(Use several sheets if necessary)

ATTY. DOCKET NO: 5150-82400

SERIAL NO: 10/809,143



APPLICANT: Cifra

FILING DATE: March 25, 2004

GROUP: 2186

U.S. PATENT DOCUMENTS

EXAM. INITIALS	REF. DES	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	A1	5,940,296	08/17/1999	Meyer			
	A2	5,481,712	01/02/1996	Silver et al.			
	A3	6,094,526	Withdrawn	Marrion et al.			
	A4	5,911,070	06/08/1999	Solton et al.			
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	A6	6,061,602	05/09/2000	Meyer			
	A7	6,763,515	07/13/2004	Vazquez et al.			
	A8	6,408,429	06/18/2002	Marrion, Jr. et al.			
	A9	4,831,580	05/1989	Yamada			
	A10	5,005,119	04/1991	Rumbaugh et al.			
	A11	6,167,562	12/2000	Kaneko			
	A12	6,226,783	05/2001	Limondin et al.			
	A13	6,298,474	10/2001	Blowers et al.			
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A16	MacUser, John Rizzo, Image Analyst and Enhance, July 1990, pp. 55-58.
A17	SPIE - The International Society for Optical Engineering, Steven Rosenthal and Larry Stahl Aerg, "Integrated Approach to Machine Vision Application Development", Volume 1386, November 8, 1990, pp. 158-162.
A18	Automatix News Release, www.applefritter.com/macclones/automatix/newsrelease , "Vision for Process Feedback and Control, 07/03/2000, pp 1-3.
A19	IPLab, Serious Image Processing for the Macintosh II, 1990.
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EXAMINER:

DATE CONSIDERED:

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the patent owner.

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| A27 | Signal Analytics Corp., "IPLab Brings Affordable Scientific Image Processing to the Macintosh II", estimated 1990 (2 pgs.). |
| A28 | Automatix Inc., "A Seminar on Machine Vision & Image Analysis", 1993, (46 pgs.).. |
| A29 | National Instruments, Measurement and Automation Catalogue, Interactive Vision Software, 1999, pp. 518-520. |
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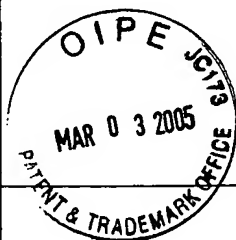
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Information Disclosure Statement--PTO 1449 (modified)

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A45	Catalano et al., "The Use of Touchsensitive video displays in on line control systems," CH1897-8/83/0000-0001, 1983 IEEE, (pages 1-6)
A46	Douglas R. Haroldsen, "Software Package lets PC Control Instruments with a Touch," Personal Computer Series, Electronic Design, October 31, 1984 (pages 180-192)
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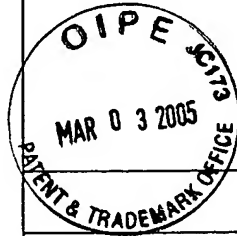
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A63	ErgoTech Systems, Inc., "TransSECS Tech Note: Building a Think & Do™: SECS Equipment Application with TransSECS™," 2001-2002(16 pages)
A64	Argonaut, "Laboratory Operating System Using Camilenet™ Network," Argonaut Technologies, CamileTG® Software, 2003 (2 pages)
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A70	Parker Automation, "Three Levels of Products," Parker Hannifin Corporation, 2003 (6 pages)
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A72	Parker Automation, "ACR-MotionMax User Interface Manual" Anything Parker Possible™, Version 1.0, April 2004 (76 pages)
A73	"Gedae: Effortless Transition Between Design and Hardware," www.gedae.com 2004 (2 pages)
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A75	T.K. Barnaby, "An Exploration of the Virtual Instrumentation Concept," Thesis presented to the University of Wales, Department of Electrical and Electronic Engineering, November 1983, (59 pages)
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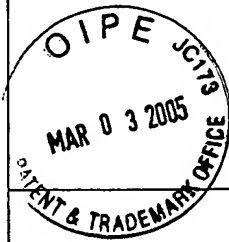
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	A77	6,839,727	1/4/05	Kechriotis			
	A78	4,570,217	2/11/86	Allen et al.			
	A79	5,309,556	5/3/94	Sismilich			
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	A86	20020191023	12/19/02	Chandhoke et al.			
	A87	20020129333	9/12/02	Chandhoke et al.			
	A88	20040221238	11/4/04	Cifra et al.			
	A89	20020186245	12/12/02	Chandhoke et al.			
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FOREIGN PATENT DOCUMENTS

EXAM. INITIAL	REF. DES	DOCUMENT NUMBER	DATE	COUNTRY	CLAS S	SUB CLASS	TRANSLATION
	A91	EP0474752	12/6/00	EP			

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